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BIB DATA SHEET

CONFIRMATION NO. 2188

RULE APPLICANTS Yoshinao Wada, Osaka, JAPAN; Shoji Okuno, Osaka, JAPAN, Deceased; Naoko Okuno, Osaka, JAPAN, Legal Representative; Ryuichi Arakawa, Hyogo, JAPAN; ** CONTINUING DATA *************************** This application is a 371 of PCT/JP05/03055 02/24/2005 *** FOREIGN APPLICATIONS ************************************	SERIAL NUM		FILING or DATI	E `´		CLASS	GR	OUP ART UNIT		ATTORNEY DOCKET NO.		
APPLICANTS Yoshinao Wada, Osaka, JAPAN; Shoji Okuno, Osaka, JAPAN, Legal Representative; Ryuichi Arakawa, Hyogo, JAPAN, Legal Representative; Ryuichi Arakawa, Hyogo, JAPAN; **CONTINUING DATA**** This application is a 371 of PCT/JP05/03055 02/24/2005 **FOREIGN APPLICATIONS*** JAPAN 2004-052521 02/26/2004 JAPAN 2004-052522 02/26/2004 JAPAN 2004-052522 02/26/2004 JAPAN 2004-052522 02/26/2004 **IF REQUIRED, FOREIGN FILING LICENSE GRANTED ** 09/03/2009 Foreign Priority claimed	10/590,823 	2				250		2881		1035-652		
Yoshinao Wada, Osaka, JAPAN, Decased; Noko Okuno, Osaka, JAPAN, Legal Representative; Ryuichi Arakawa, Hyogo, JAPAN, Legal Representative; Ryuichi Arakawa, Hyogo, JAPAN, Legal Representative; Ryuichi Arakawa, Hyogo, JAPAN; ***CONTINUING DATA **********************************			RULI	E								
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35 USC 119(a-d) conditions met 2 Yes No Verified and /NICOLE IPPOLITO RAUSCH/ Examiner's Signature Initials DAPAN 9 19 4 Acknowledged Examiner's Signature Initials DAPAN 9 19 4 ACKNOWLEDGED TO RAUSCH/ Examiner's Signature Initials DAPAN 9 19 4 ACKNOWLEDGED TO RAUSCH/ Examiner's Signature Initials DAPAN 9 19 4 ACKNOWLEDGED TO RAUSCH/ Examiner's Signature Initials DAPAN 9 19 4 ACKNOWLEDGED TO RAUSCH/ Examiner's Signature Initials DAPAN 9 19 4 ACKNOWLEDGED TO RAUSCH/ Examiner's Signature Initials DAPAN 9 19 4 ACKNOWLEDGED TO RAUSCH/ Examiner's Signature Initials DAPAN 9 19 4 ACKNOWLEDGED TO RAUSCH/ Examiner's Signature Initials DAPAN 9 19 4 ACKNOWLEDGED TO RAUSCH/ Examiner's Signature Initials DAPAN 9 19 4 ACKNOWLEDGED TO RAUSCH/ Examiner's Signature Initials DAPAN 9 19 4 ACKNOWLEDGED TO RAUSCH/ Examiner's Signature Initials DAPAN 9 19 4 ACKNOWLEDGED TO RAUSCH/ Examiner's Signature Initials DAPAN 9 19 4 ACKNOWLEDGED TO RAUSCH/ Examiner's Signature Initials DAPAN 9 19 4 ACKNOWLEDGED TO RAUSCH/ Examiner's Signature Initials DAPAN 9 19 4 ACKNOWLEDGED TO RAUSCH/ Examiner's Signature Initials DAPAN 9 19 4 ACKNOWLEDGED TO RAUSCH/ Examiner's Signature Initials DAPAN 9 19 4 ACKNOWLEDGED TO RAUSCH/ Examiner's Signature Initials DAPAN 9 19 19 4 ACKNOWLEDGED TO RAUSCH/ Examiner's Signature Initials DAPAN 9 19 19 4 ACKNOWLEDGED TO RAUSCH/ Examiner Initials DAPAN 9 19 19 4 ACKNOWLEDGED TO RAUSCH/ Examiner Initials DAPAN 9 19 19 4 ACKNOWLEDGED TO RAUSCH/ Examiner Initials DAPAN 9 19 19 4 ACKNOWLEDGED TO RAUSCH/ Examiner Initials DAPAN 9 19 19 19 4 ACKNOWLEDGED TO RAUSCH/ Examiner Initials DAPAN 9 19 19 19 19 19 19 19 19 19 19 19 19 1	** IF REQUIRED, FOREIGN FILING LICENSE GRANTED ** 09/03/2009											
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